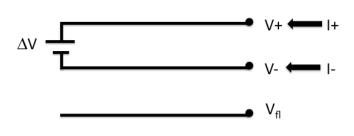


Exercise I: Considerations around the design of a Langmuir probe? (1 hour)

A) TRIPLE PROBE: FORMULE DERIVATION



Prove the formula:

$$T_e = \frac{e}{k \ln(2)} \Big(V_+ - V_{fl} \Big)$$

for the Triple probe configuration, assuming that the double probe circuit bias $\Delta V >> T_e$.

Recalling that $I = I_{sat} \left(1 - e^{\frac{V - V_{fl}}{kT_e/e}} \right)$ where $I_{sat} = A_p I_{sat} = A_p e^{\frac{n}{2}c_s}$ and considering that the double probe circuit is floating, we have $I_+ = -I_-$.

$$I_{sat}\left(1 - e^{\frac{V_{+} - V_{fl}}{kT_{e}/e}}\right) = -I_{sat}\left(1 - e^{\frac{V_{-} - V_{fl}}{kT_{e}/e}}\right) \quad \Rightarrow \quad 1 - e^{\frac{V_{+} - V_{fl}}{kT_{e}/e}} = -1 + e^{\frac{V_{-} - V_{fl}}{kT_{e}/e}} \quad \Rightarrow \quad 2 = e^{\frac{V_{+} - V_{fl}}{kT_{e}/e}} + e^{\frac{V_{-} - V_{fl}}{kT_{e}/e}}$$

$$\Rightarrow 2 = e^{\frac{V_{+} - V_{fl}}{kT_{e}/e}} \left(1 + e^{\frac{V_{-} - V_{fl} - V_{+} + V_{fl}}{kT_{e}/e}} \right), \text{ using } V_{-} - V_{+} = -\Delta V \Rightarrow 2 = e^{\frac{V_{+} - V_{fl}}{kT_{e}/e}} \left(1 + e^{\frac{-\Delta V}{kT_{e}/e}} \right).$$

Now we assume that $\Delta V >> kT_e/e$, therefore $e^{-\frac{\Delta V}{kT_e/e}} <<1$ and so $2 = e^{\frac{V_+ - V_{fl}}{kT_e/e}}$ and we finally obtain: $\ln(2) = \frac{e(V_+ - V_{fl})}{kT_e} \implies T_e = \frac{e}{k\ln(2)}(V_+ - V_{fl})$

B) TRIPLE PROBE WITH CORRECTION FOR SHEATH EXPANSION

How is modified the previous formula when the sheath expansion is taken into account?

We model the sheath expansion with the following formula: $I = I_{sat} \left[1 - \alpha \left(V - V_{fl} \right) - \exp \left(\frac{V - V_{fl}}{kT_e/e} \right) \right].$ Now we consider the floating double probe circuit, where $I_+ = -I_-$ must hold.

$$I_{+} = I_{sat} \left[1 - \alpha \left(V_{+} - V_{fl} \right) - \exp \left(\frac{V_{+} - V_{fl}}{k T_{e} / e} \right) \right] \quad \text{and} \quad I_{-} = I_{sat} \left[1 - \alpha \left(V_{-} - V_{fl} \right) - \exp \left(\frac{V_{-} - V_{fl}}{k T_{e} / e} \right) \right]$$

$$\Rightarrow \quad 1 - \alpha \left(V_{+} - V_{fl} \right) - \exp \left(\frac{V_{+} - V_{fl}}{k T_{e} / e} \right) = -1 + \alpha \left(V_{-} - V_{fl} \right) + \exp \left(\frac{V_{-} - V_{fl}}{k T_{e} / e} \right)$$

$$\Rightarrow 2 = \alpha \left(V_{+} - V_{fl}\right) + \alpha \left(V_{-} - V_{fl}\right) + \exp\left(\frac{V_{+} - V_{fl}}{kT_{e}/e}\right) + \exp\left(\frac{V_{-} - V_{fl}}{kT_{e}/e}\right)$$

$$\Rightarrow 2 = \alpha V_{+} + \alpha V_{-} - 2\alpha V_{fl} + \exp\left(\frac{V_{+} - V_{fl}}{kT_{e}/e}\right) \left[1 + \frac{\exp\left(\frac{V_{-} - V_{fl}}{kT_{e}/e}\right)}{\exp\left(\frac{V_{+} - V_{fl}}{kT_{e}/e}\right)}\right].$$

Now adding and substituting $\alpha V_{^+},$ and using $V_{^+}$ - $V_{^-}$ = $\Delta V,$ we have:

$$\Rightarrow 2 = \alpha V_+ + \alpha V_+ - \alpha V_+ + \alpha V_- - 2\alpha V_{fl} + \exp\left(\frac{V_+ - V_{fl}}{kT_e/e}\right) \left[1 + \exp\left(\frac{-\Delta V}{kT_e/e}\right)\right]$$

Using the fact that $\Delta V \gg kT_e/e$,

$$\Rightarrow 2 = 2\alpha \left(V_{+} - V_{fl}\right) - \alpha \Delta V + \exp\left(\frac{V_{+} - V_{fl}}{kT_{e}/e}\right) \Rightarrow 2 - 2\alpha \left(V_{+} - V_{fl}\right) + \alpha \Delta V = \exp\left(\frac{V_{+} - V_{fl}}{kT_{e}/e}\right)$$

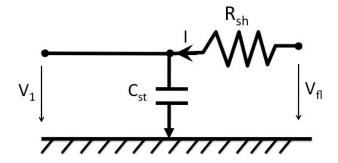
$$\ln \left[2 - 2\alpha \left(V_+ - V_{fl} \right) + \alpha \Delta V \right] = \frac{V_+ - V_{fl}}{k T_e / e} \quad \Rightarrow \quad T_e = \frac{e \left(V_+ - V_{fl} \right)}{k \ln \left[2 - 2\alpha \left(V_+ - V_{fl} \right) + \alpha \Delta V \right]}$$

C) THE EFFECT OF THE SHEATH

Prove that the presence of a sheath in front of a probe, which is biased at the floating potential, results in a limitation of the frequency response of the probe itself.

Using the formula for the current driven by a LP $I = I_{sat} \left(1 - e^{\frac{V - V_{fl}}{kT_e/e}} \right)$ and assuming that the probe is biased close to the floating potential, we have $V \sim V_{fl}$, therefore $\frac{V - V_{fl}}{T_e} \ll 1$. We can then expand the exponential:

$$I \approx I_{sat} \left(1 - 1 + \frac{V - V_{fl}}{k T_e / e} \right) \approx \frac{I_{sat}}{k T_e / e} \Delta V \implies R_{sh} = \frac{k T_e}{e I_{sat}} \text{ where } I_{sat} = A_p I_{sat} = A_p e \frac{n}{2} c_s.$$



We can now consider a real LP whose signal is transported and acquired via a cable with a stray capacitance to the ground (typically $C_{st} \sim 100$ pF/m). A resistance and a capacitance in series can model this effect. This circuit behaves like a low-pass filter.

The current circulating through the resistance is given by: $V_{fl} - V_1 = R_{sh} I$ and the current through the capacitance is given by: $I = C_{st} \frac{dV_1}{dt}$ (since the impedance is infinite).

Since it is a series circuit, the Kirshhoff's law states that currents must be equal:

$$I = \frac{V_{fl} - V_1}{R_{sh}} = C_{st} \frac{dV_1}{dt} \implies (1 + j\omega R_{sh} C_{st}) \hat{V}_1 = \hat{V}_{fl} \text{ where we have used the Fourier transform of}$$
the signal $\hat{V}(\omega) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} V(t) e^{j\omega t} dt$

The cut-off frequency is defined as the frequency for which the amplitude of the output voltage is attenuated by $\sqrt{2}$ (which corresponds to -3 dB) w.r.t. the amplitude of the input voltage:

$$G_{C} = \left| \frac{\hat{V}_{1}}{\hat{V}_{fl}} \right| = \frac{1}{\sqrt{1 + \left(\omega C_{st} R_{sh}\right)^{2}}} = \frac{1}{\sqrt{2}} \implies 2 = 1 + \omega^{2} \left(C_{st} R_{sh}\right)^{2} \Rightarrow$$

$$\omega_{cutoff} = \frac{1}{R_{ch} C_{st}} \Rightarrow f_{cutoff} = \frac{1}{2\pi R_{sh} C_{st}}$$

We note also that a sheath capacitance may be present, which can be estimated as: $C_{sh} \sim \frac{\varepsilon_0 A}{\lambda_D}$. This is usually very small (for TORPEX, $C_{sh} \sim 0.5$ pF).

Examples:

TORPEX: H_2 plasma, $T_e \sim 5 \text{ eV} - n_e \sim 10^{16} \text{ m}^{-3} - A \sim 10^{-5} \text{ m}^2 - C_{sh} \sim 0.5 \text{ pF} - 3 \text{ m cables}$:

→ R_{sh} = eT_e/I_{sat} with
$$I_{sat} = Ae\frac{n}{2}C_s$$
 and C_s = 9.79x10³(γZT_e/μ)^{1/2}m.s⁻¹ → C_s ~ 2.8x10⁴ m.s⁻¹
→ I_{sat} ~ 2.3x10⁻⁴ A → R_{sh}= 2.2x10⁴ Ω → f_{cutoff} = 2.4x10⁴ Hz (C_{st} = 300 pF)

TCV: D_2 plasma, $T_e \sim 50$ eV - $n_e \sim 10^{19}$ m⁻³ - A $\sim 10^{-5}$ m² - $C_{sh} \sim 0.5$ pF - 10 m cables: R_{sh} ? f_{cutoff} ?

$$\rightarrow$$
 Z=1, μ=2 \rightarrow C_s \sim 6.3x10⁴ m.s⁻¹ \rightarrow I_{sat} \sim 0.5 A \rightarrow R_{sh} \sim 98 Ω \rightarrow f_{cutoff} \sim 1.6x10⁶ Hz (C_{st} \sim 1000 pF)

Note that this limits the sweep frequency and it also introduces a phase delay, which may leads to error in the evolution of the particle flux.

Reference: Practical solutions for reliable triple probe measurements in magnetized plasmas by C. Theiler, I. Furno, A. Kuenlin, P. Marmillod and A. Fasoli in Review of Scientific Instruments, vol. 82, p. 013504, 2011.

https://en.wikipedia.org/wiki/RC circuit